Search Notes			

Application/Control No	o. Applicant(s)/Patent und Reexamination	er
10/604,709	JONG, CHIOU-MUH	
Examiner	Art Unit	
Jin-Cheng Wang	2628	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
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EAST	6/17/2006	JCW
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